Application/Control No. Applicant(s)/Patent Under Reexamination 10/678,766 TOIS ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1765 Matthew J Song **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 427/255.23 US-6,015,590 01-2000 Suntola et al. Α US-5,891,744 04-1999 438/14 Lowrey et al. В US-C US-D US-Ε F US-G US-US-Н US-US-US-K L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Suntola, "Atomic Layer Epitaxy", 12-1989, Materials Science Reports, Vol 4, Num 7, pp 261-312.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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